

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination IMACHI ET AL.	
			Examiner Helen O. Chu	Art Unit 1745	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0051910	05-2002	Yoshimura et al.	429/249
*	B	US-2003/0073005	04-2003	Kim et al.	429/326
	C	US-			
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	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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